Haluleder - Chapter 4

E=ht=his, absorbed if hr>Eg.

· First louninement process: flourescence } transient decay.

Et = impurity energy level.

· Photoconductivity: increased conductivity originated from excess EHPs from light.

" dr = constant of propertionality for recombination.

· In(t) = Sp(t) = excess carrier concentrations.

Dn = initial excess electron concentration at t=0.

-> p-type: don(t) = - arpon(t) = Don(t) = Dne are.t = Dne

Tn = (drp) = recombination lifetime or minority carrier litetime (1p).

 $T_p = (d_r n_o)^{-1}$

- generally: In = carrier litetime = dr(no + Po)

· Er = recombination energy level. If an electron falls from Er to valence band, and then another falls from conduction band to Er, we have had an indirect recombination.

- Temporary trapping, IT, can also occur.

· Conductivity during photoconductive decay: $\sigma(t) = q(n(t), r_n + p(t), r_p)$ Process of photoconductive decay measurements can be used for characterization

g(T) = 9; = EAP generation out equilibrium (thermal generation).

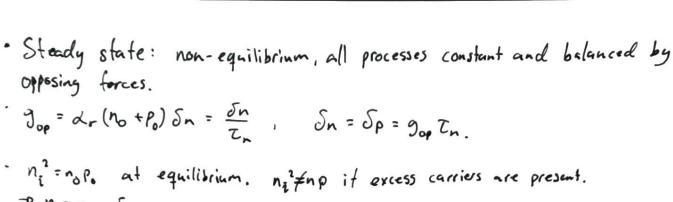
-> g(7) = drn= = drn.p.

gop = optical EHP generation rate (light source)

- 9(T) + 90p = drnp = αr(no + δn/(Po + δp)

- Steady state and no trapping: g(T) + gop = armopo + ar ((no + p.) dn + dn)

- Equilibrium: no external excitation except temperature, no net motion of Charge.



$$P = N_0 + Sn$$

In this case, the excitation causes a large percentage change in minority carrier hole concentration and a relatively small change in electron concentration.

· Photons with hy >> Eg are absorbed at the surface and contribute little to the bulk conductivity.

- · Diffusion: movement from high potential to low potential, due to random motion.
- · Current conduction consists of diffusion due to carrier gradient, and drift in an electric field.
- · Ex.: pulse spread by diffusion.

 Mean free path I increases as $n(x_{i,t})$ diffuses.

The rate of electron flow in the
$$\hat{\alpha}$$
-direction per unit area;
$$\phi_n(x_0) = \frac{\bar{\epsilon}}{2\bar{\epsilon}}(n_1 - n_2)$$

MATH gives: $\phi_n(x) = -\frac{e^2}{2T} \cdot \frac{dn(x)}{dx} = -D_n \frac{dn(x)}{dx}$ where Dn is called the electron diffusion coefficient, [Dn]: cm/s. and $\phi_{\rho}(\mathbf{x}) = -D_{\rho} \frac{d\rho(\mathbf{x})}{d\rho}$

$$J_{p,diff} = +q D_{p} \frac{dn(\omega)}{dx}$$

$$J_{p,diff} = -q D_{p} \frac{dp(\omega)}{dx}$$

If electric field is also present:

$$J_{n}(x) = 2 p_{n} n(x) E(x) + 2 D_{n} \frac{dn(x)}{dx}$$

$$driff \qquad diffusion$$

$$J_{p}(x) = 4 p_{p} p(x) E(x) - 4 D_{p} \frac{dp(x)}{dx}$$

$$J(x) = J_{n}(x) + J_{p}(x)$$

- Manority carrier currents through diffusion can sometimes be as large as majority carrier currents. (gradient).

In, lift
$$-\theta$$

In, lift $+\theta$

In, wift $+\phi$

In, wift $+\phi$

$$\int_{n_1, n_2} dt f + \phi$$

$$\int_{n_1, n_2} dt f + \phi$$

$$\int_{n_2, n_3} dt f + \phi$$

$$\int_{n_3, n_4} dt f + \phi$$

$$\int_{n_3, n$$

Pracift -0

Priditt ->

$$\varepsilon_i$$

$$E(x) = \frac{p_0}{p_0} \frac{1}{p_0(x)} \frac{dp(x)}{dx}, \text{ so } \frac{D}{p} = \frac{k_0 T}{7} = \text{Einstein relation.}$$

· One-dimensional continuity aguation for holes:

$$\frac{\partial \delta p(x,t)}{\partial t} = \frac{1}{9} \frac{\partial J_p(x)}{\partial x} - \frac{\delta P(x,t)}{\zeta_p}$$

The Electrons:
$$\frac{\partial Sn}{\partial t} = \frac{1}{9} \frac{\partial J_n}{\partial x} - \frac{Sn}{E_n}$$
.

"When currents is carried strictly by diffusion, we get the diffusion

$$\frac{\partial \delta n}{\partial t} = D_n \frac{\partial \delta n}{\partial x^2} - \frac{\delta n}{\tau_n} \quad \frac{\partial \delta p}{\partial t} = D_p \frac{\partial \delta p}{\partial x^2} - \frac{\partial p}{\tau_p}$$

Steady state:
$$\frac{d^2 S_n}{dx^2} = \frac{S_n}{D_n T_n} = \frac{S_n}{L_n^2}, \frac{d^2 S_p}{dx^2} = \frac{S_p}{D_p T_p} = \frac{S_p}{L_p^2}$$

Electron diffusion length $L_n = \int D_n T_n$, hole ... $L_p = \int D_p T_p$.

Solution to steady state equs.: $\int n(x) = \delta n e^{-x/L_n}$, $\int p(x) = \Delta p e^{-x/L_p}$.

Average distance a carrier diffuses before recombining.

